

**VCCI-CISPR 32**

**TEST REPORT**

*For*

**USB Flash Drives**

**MODEL NUMBER: ACE**

**REPORT NUMBER: 4790869091.1-3**

**ISSUE DATE: June 29, 2023**

*Prepared for*

**Flashbay Electronics**

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*Prepared by*

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## Revision History

<u>Rev.</u>	<u>Issue Date</u>	<u>Revisions</u>	<u>Revised By</u>
V0	6/29/2023	Initial Issue	

Summary of Test Results				
Standard	Test Item	Limit	Result	Remark
VCCI-CISPR 32:2016	Conducted emissions from the AC mains power ports	Class B	Pass	
	Asymmetric mode conducted emissions	Class B	N/A	NOTE (1)
	Radiated emissions at frequencies up to 1 GHz	Class B	Pass	
	Radiated emissions at frequencies above 1 GHz	Class B	Pass	NOTE (2)

**Note:**

- (1) "N/A" denotes test is not applicable in this Test Report
- (2) If the highest frequency of the internal sources of the EUT is less than 108 MHz, the measurement shall only be made up to 1 GHz. If the highest frequency of the internal sources of the EUT is between 108 MHz and 500 MHz, the measurement shall only be made up to 2 GHz. If the highest frequency of the internal sources of the EUT is between 500 MHz and 1 GHz, measurement shall only be made up to 5 GHz. If the highest frequency of the internal sources of the EUT is above 1 GHz, the measurement shall be made up to 5 times the highest frequency or 6 GHz, whichever is less.
- (3) This test report is only published to and used by the applicant, and it is not for evidence purpose in China.
- (4) The measurement result for the sample received is <Pass> according to < VCCI-CISPR 32:2016 > when <Accuracy Method> decision rule is applied.

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# 1. ATTESTATION OF TEST RESULTS

## Applicant Information

Company Name: Flashbay Electronics  
 Address: Building2, Jixun Industrial Park, Xinjiao, Dong'ao Village, Shatian Town, Huiyang District, Huizhou City, Guangdong Province, P.R.China

## Manufacturer Information

Company Name: Flashbay Electronics  
 Address: Building2, Jixun Industrial Park, Xinjiao, Dong'ao Village, Shatian Town, Huiyang District, Huizhou City, Guangdong Province, P.R.China

## EUT Information

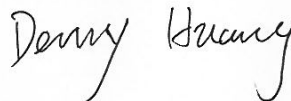
EUT Name: USB Flash Drives  
 Model: ACE  
 Brand: /  
 Sample Received Date: June 12, 2023  
 Sample Status: Normal  
 Sample ID: 6170594  
 Date of Tested: June 14, 2023 ~ June 27, 2023

APPLICABLE STANDARDS	
STANDARDS	TEST RESULTS
VCCI-CISPR 32:2016	PASS

Prepared By:



Checked By:



Andy Xiong  
 Engineer Project Associate

Denny Huang  
 Senior Project Engineer

Approved By:



Stephen Guo  
 Laboratory Manager

## 2. TEST METHODOLOGY

All tests were performed in accordance with the standard VCCI-CISPR 32:2016.

## 3. FACILITIES AND ACCREDITATION

Accreditation Certificate	<p><b>A2LA (Certificate No.: 4102.01)</b>                  UL Verification Services (Guangzhou) Co., Ltd. Song Shan Lake Branch. has been assessed and proved to be in compliance with A2LA.</p> <p><b>FCC (FCC Recognized No.: CN1187)</b>                  UL Verification Services (Guangzhou) Co., Ltd. Song Shan Lake Branch. Has been recognized to perform compliance testing on equipment subject to the Commission's Declaration of Conformity (DoC) and Certification rules</p> <p><b>IC(Company No.: 21320)</b>                  UL Verification Services (Guangzhou) Co., Ltd. Song Shan Lake Branch. has been registered and fully described in a report filed with Industry Canada. The Company Number is 21320.</p> <p><b>VCCI (Registration No.: G-20019, R-20004, C-20012 and T-20011)</b>                  UL Verification Services (Guangzhou) Co., Ltd. Song Shan Lake Branch. has been assessed and proved to be in compliance with VCCI, the Membership No. is 3793.                  Facility Name:                  Chamber D, the VCCI registration No. is G-20019 and R-20004                  Shielding Room B , the VCCI registration No. is C-20012 and T-20011</p>
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Note: All tests measurement facilities use to collect the measurement data are located at Building 10, Innovation Technology Park, No. 1, Li Bin Road, Song Shan Lake Hi-Tech Development Zone Dongguan, 523808, People's Republic of China

## 4. CALIBRATION AND UNCERTAINTY

### 4.1. Measuring Instrument Calibration

The measuring equipment utilized to perform the tests documented in this report has been calibrated in accordance with the manufacturer's recommendations, and is traceable to recognized national standards.

### 4.2. Measurement Uncertainty

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the apparatus:

Test Item	Measurement Frequency Range	K	U(dB)
Conducted emissions from the AC mains power ports	0.009 MHz ~ 0.15 MHz	2	4.00
Conducted emissions from the AC mains power ports	0.15 MHz ~ 30 MHz	2	3.62
Asymmetric mode conducted emissions – Asymmetric Artificial Network	0.15 MHz ~ 30 MHz	2	5.04
Asymmetric mode conducted emissions – current probe	0.15 MHz ~ 30 MHz	2	3.48
Radiated emissions	30 MHz ~ 1G Hz	2	4.00
Radiated emissions	1 GHz ~ 18 GHz	2	5.78

Note: This uncertainty represents an expanded uncertainty expressed at approximately the 95 % confidence level using a coverage factor of k=2.

## 5. EQUIPMENT UNDER TEST

### 5.1. Description of EUT

EUT Name	USB Flash Drives
Model	ACE
Ratings	Input: 5 Vdc

### 5.2. Test Mode

Test Mode	Description
Mode 1	Data Transfer & USB Port Connected
Mode 2	Data Transfer & Type-C Port Connected

### 5.3. EUT Accessory

Item	Accessory	Brand Name	Model Name	Description
/	/	/	/	/

### 5.4. Support Units or Accessories for System Test

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Item	Equipment	Mfr/Brand	Model/Type No.	Specification	Series No.
E-1	Laptop	Lenovo	Thinkpad T14 Gen 1	N/A	PF-39TXGN
E-2	PC	Alienware	R12	N/A	1Z4FYF3
E-3	Monitor	Dell	U2720Q	N/A	CN-09MRJJ-WSL00-1BQ-CMPL-A11
E-4	Keyboard	Lenovo	KU-0025	N/A	1S41A52891000484E
E-5	Mouse	Dell	MS116C	N/A	CN-0DMV3P-CH400-030-0JQ8-A00

The following cables were used to form a representative test configuration during the tests.

Item	Type of cable	Shielded Type	Ferrite Core	Specification
E-1	HDMI Cable	Shielded	NO	1.5 m



## 6. MEASURING EQUIPMENT AND SOFTWARE USED

Conducted Emissions					
Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Due Date
EMI Test Receiver	ROHDE & SCHWARZ	ESR3	101961	Oct. 17, 2022	Oct. 16, 2023
Two-Line V-Network	ROHDE & SCHWARZ	ENV216	101983	Oct. 17, 2022	Oct. 16, 2023
Artificial Mains Networks	Schwarzbeck	NSLK 8126	8126465	Oct. 17, 2022	Oct. 16, 2023
Software					
Description			Manufacturer	Name	Version
Test Software for Conducted Emissions			Farad	EZ-EMC	Ver. UL-3A1
Radiated Emissions					
Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Due Date
MXE EMI Receiver	KESIGHT	N9038A	MY56400036	Oct. 17, 2022	Oct. 16, 2023
Hybrid Log Periodic Antenna	TDK	HLP-3003C	130960	Aug. 2, 2021	Aug. 1, 2024
Preamplifier	HP	8447D	2944A09099	Oct. 17, 2022	Oct. 16, 2023
EMI Measurement Receiver	ROHDE & SCHWARZ	ESR26	101377	Oct. 17, 2022	Oct. 16, 2023
Horn Antenna	TDK	HRN-0118	130940	Jul. 20, 2021	Jul. 19, 2024
Preamplifier	TDK	PA-02-0118	TRS-305-00067	Oct. 17, 2022	Oct. 16, 2023
Software					
Description			Manufacturer	Name	Version
Test Software for Radiated Emissions			Farad	EZ-EMC	Ver. UL-3A1
Other Instrument					
Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Due Date
Temperature humidity probe	OMEGA	ITHX-SD-5	18470007	Oct. 22, 2022	Oct. 21, 2023
Barometer	Yiyi	Baro	N/A	Oct. 22, 2022	Oct. 21, 2023

## 7. EMISSION TEST

### 7.1. Conducted Emissions Measurement

#### 7.1.1. Limits of Conducted Emissions

(a.) Limits of conducted emissions from the AC mains power ports of Class A equipment

Frequency range MHz	Coupling device	Detector type / bandwidth	Class A voltage limits dB(uV)
0.15 to 0.5	AMN	Quasi Peak / 9 kHz	79
0.5 to 30			73
0.15 to 0.5	AMN	Average / 9 kHz	66
0.5 to 30			60

(b.) Limits of conducted emissions from the AC mains power ports of Class B equipment

Frequency range MHz	Coupling device	Detector type / bandwidth	Class B voltage limits dB(uV)
0.15 to 0.5	AMN	Quasi Peak / 9 kHz	66 to 56
0.5 to 5			56
5 to 30			60
0.15 to 0.5	AMN	Average / 9 kHz	56 to 46
0.5 to 5			46
5 to 30			50

(c.) Limits of asymmetric mode conducted emissions of Class A equipment

Frequency range MHz	Coupling device	Detector type / bandwidth	Class A voltage limits dB(uV)	Class A current limits dB(uA)
0.15 -0.5	AAN	Quasi Peak / 9 kHz	97 to 87	n/a
0.5 -30			87	n/a
0.15 -0.5	AAN	Average / 9 kHz	84 to 74	n/a
0.5 -30			74	n/a
0.15 -0.5	Current Probe	Quasi Peak / 9 kHz	n/a	53 to 43
0.5 -30			n/a	43
0.15 -0.5	Current Probe	Average / 9 kHz	n/a	40 to 30
0.5 -30			n/a	30

## (d.) Limits of asymmetric mode conducted emissions of Class B equipment

Frequency range MHz	Coupling device	Detector type / bandwidth	Class B voltage limits dB(uV)	Class B current limits dB(uA)
0.15 -0.5	AAN	Quasi Peak / 9 kHz	84 to 74	n/a
0.5 -30			74	n/a
0.15 -0.5	AAN	Average / 9 kHz	74 to 64	n/a
0.5 -30			64	n/a
0.15 -0.5	Current Probe	Quasi Peak / 9 kHz	n/a	40 to 30
0.5 -30			n/a	30
0.15 -0.5	Current Probe	Average / 9 kHz	n/a	30 to 20
0.5 -30			n/a	20

Note:

(1)The tighter limit applies at the band edges.

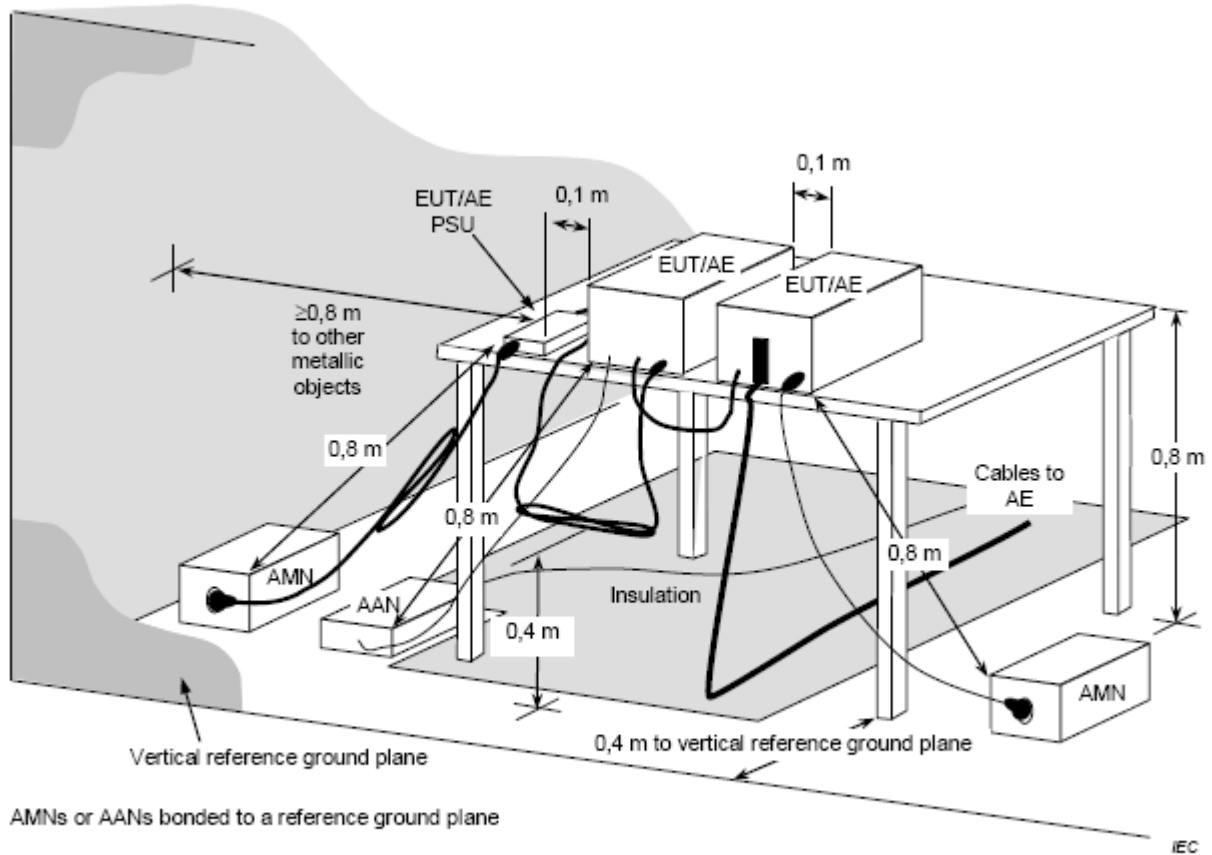
(2)The limit of " \* " marked band means the limitation decreases linearly with the logarithm of the frequency in the range.

### 7.1.2. Test Procedure

- a. The EUT was placed 0.8 meters from the horizontal ground plane
- b. Interconnecting cables that hang closer than 40 cm to the ground plane shall be folded back and forth in the center forming a bundle 30 to 40 cm long.
- c. I/O cables that are not connected to a peripheral shall be bundled in the center. The end of the cable may be terminated, if required, using the correct terminating impedance. The overall length shall not exceed 1 m.
- d. AMN/ANN at least 80 cm from nearest part of EUT chassis.
- e. For the actual test configuration, please refer to the related Item: Photographs of Test Configuration

### 7.1.3. Test Setup

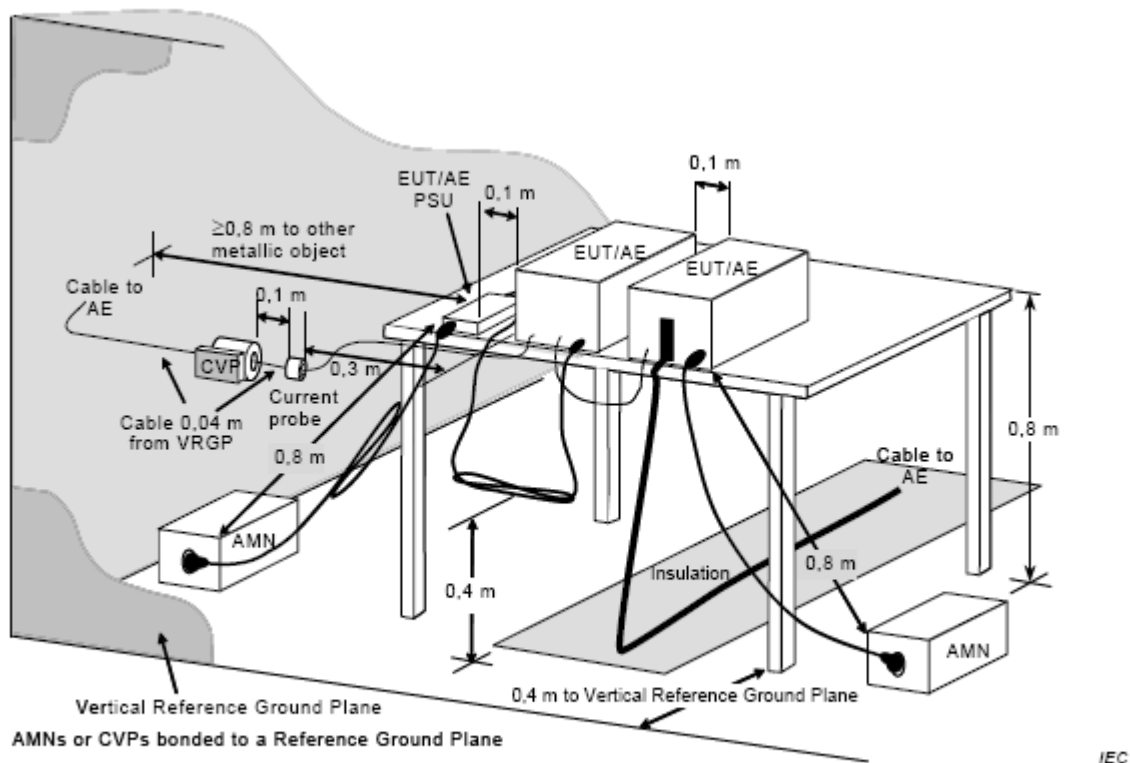
(a.) Example measurement arrangement for table-top EUT (alternative 1)



The 0,8 m distance specified between EUT/AE/PSU and AMN/AAN, is applicable only to the EUT being measured. If the device is AE then it shall be  $\geq 0,8$  m.

For the actual test configuration, please refer to Appendix I: Photographs of Test Configuration

(b.) Example measurement arrangement for table-top EUT measuring in accordance with C.4.1.6.4



The 0,8 m distance specified between EUT/local AE/PSU and AMN/AAN, is applicable only to the EUT being measured. If the device is AE then it shall be  $\geq 0,8$  m.

For the actual test configuration, please refer to Appendix I: Photographs of Test Configuration

### 7.1.4. Test Environment

Temperature:	25.2 °C
Humidity:	51.3 %
ATM pressure:	101 kPa

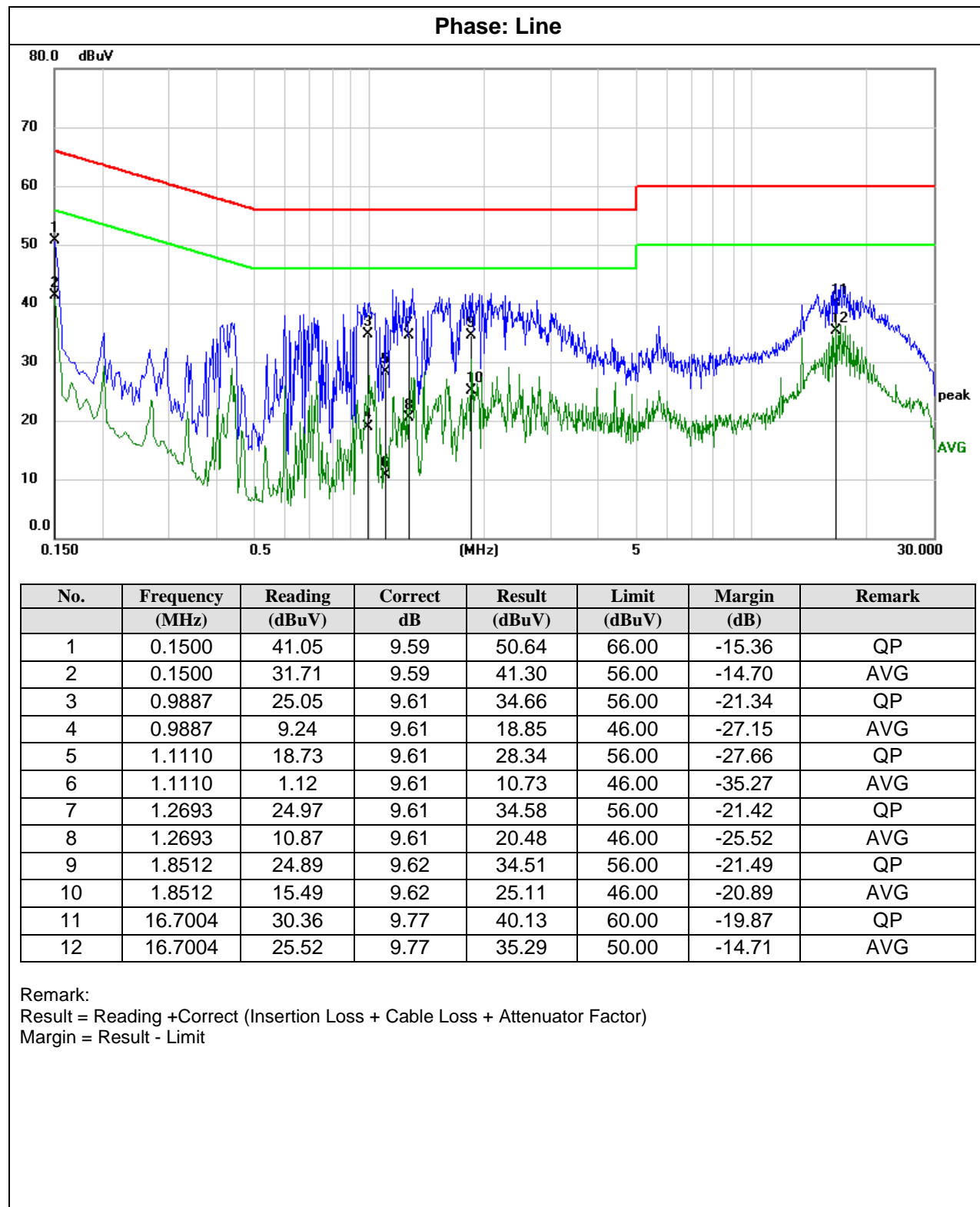
### 7.1.5. Test Mode

Pre-test Mode:	Mode 1 & Mode 2
Final Test Mode:	Mode 2

Note: All test modes have been tested, but only the worst case data recorded in the report.

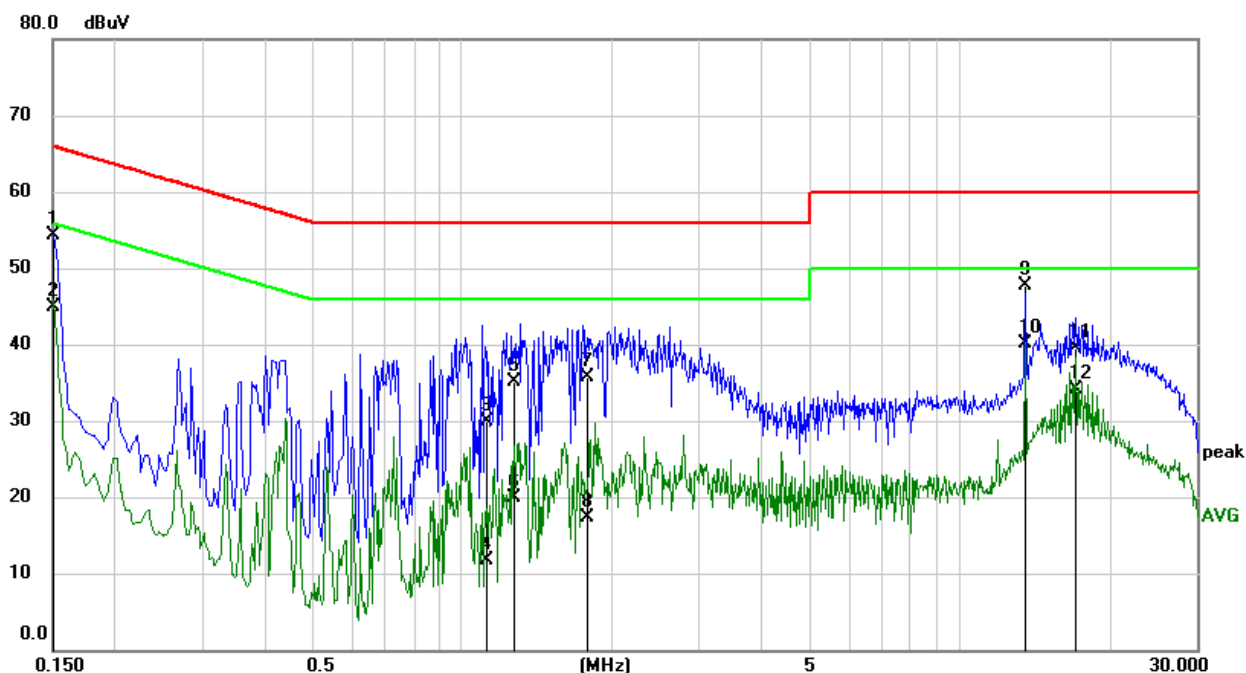
### 7.1.6. Test Results - AC mains power ports

Test Mode:	Mode 2
Test Voltage:	AC 100V/60 Hz



Test Mode:	Mode 2
Test Voltage:	AC 100V/60 Hz

**Phase: Neutral**



No.	Frequency (MHz)	Reading (dBuV)	Correct (dB)	Result (dBuV)	Limit (dBuV)	Margin (dB)	Remark
1	0.1500	40.84	9.59	50.43	66.00	-15.57	QP
2	0.1500	31.31	9.59	40.90	56.00	-15.10	AVG
3	0.9871	25.35	9.61	34.96	56.00	-21.04	QP
4	0.9871	8.78	9.61	18.39	46.00	-27.61	AVG
5	1.2009	23.38	9.61	32.99	56.00	-23.01	QP
6	1.2009	8.68	9.61	18.29	46.00	-27.71	AVG
7	1.5245	24.98	9.62	34.60	56.00	-21.40	QP
8	1.5245	8.09	9.62	17.71	46.00	-28.29	AVG
9	1.8079	27.05	9.62	36.67	56.00	-19.33	QP
10	1.8079	15.56	9.62	25.18	46.00	-20.82	AVG
11	16.4629	29.23	9.76	38.99	60.00	-21.01	QP
12	16.4629	24.45	9.76	34.21	50.00	-15.79	AVG

Remark:

Result = Reading + Correct (Insertion Loss + Cable Loss + Attenuator Factor)

Margin = Result - Limit

## 7.2. Radiated Emissions Measurement

### 7.2.1. Limits of Radiated Emissions Measurement

#### (a). Limits up to 1 GHz

FREQUENCY (MHz)	Class A		Class B	
	At 10m	At 3m	At 10m	At 3m
	dB $\mu$ V/m	dB $\mu$ V/m	dB $\mu$ V/m	dB $\mu$ V/m
30 – 230	40	50	30	40
230 – 1000	47	57	37	47

#### (b). Limits above 1 GHz

FREQUENCY (MHz)	Class A (at 3m) dB $\mu$ V/m		Class B (at 3m) dB $\mu$ V/m	
	Peak	Avg	Peak	Avg
1000-3000	76	56	70	50
3000-6000	80	60	74	54

Note:

- (1) The limit for radiated test was performed according to CISPR 32.
- (2) The tighter limit applies at the band edges.
- (3) Emission level (dB $\mu$ V/m)=20log Emission level (uV/m).
- (4) If the highest frequency of the internal sources of the EUT is less than 108 MHz, the measurement shall only be made up to 1 GHz. If the highest frequency of the internal sources of the EUT is between 108 MHz and 500 MHz, the measurement shall only be made up to 2 GHz. If the highest frequency of the internal sources of the EUT is between 500 MHz and 1 GHz, measurement shall only be made up to 5 GHz. If the highest frequency of the internal sources of the EUT is above 1 GHz, the measurement shall be made up to 5 times the highest frequency or 6 GHz, whichever is less.

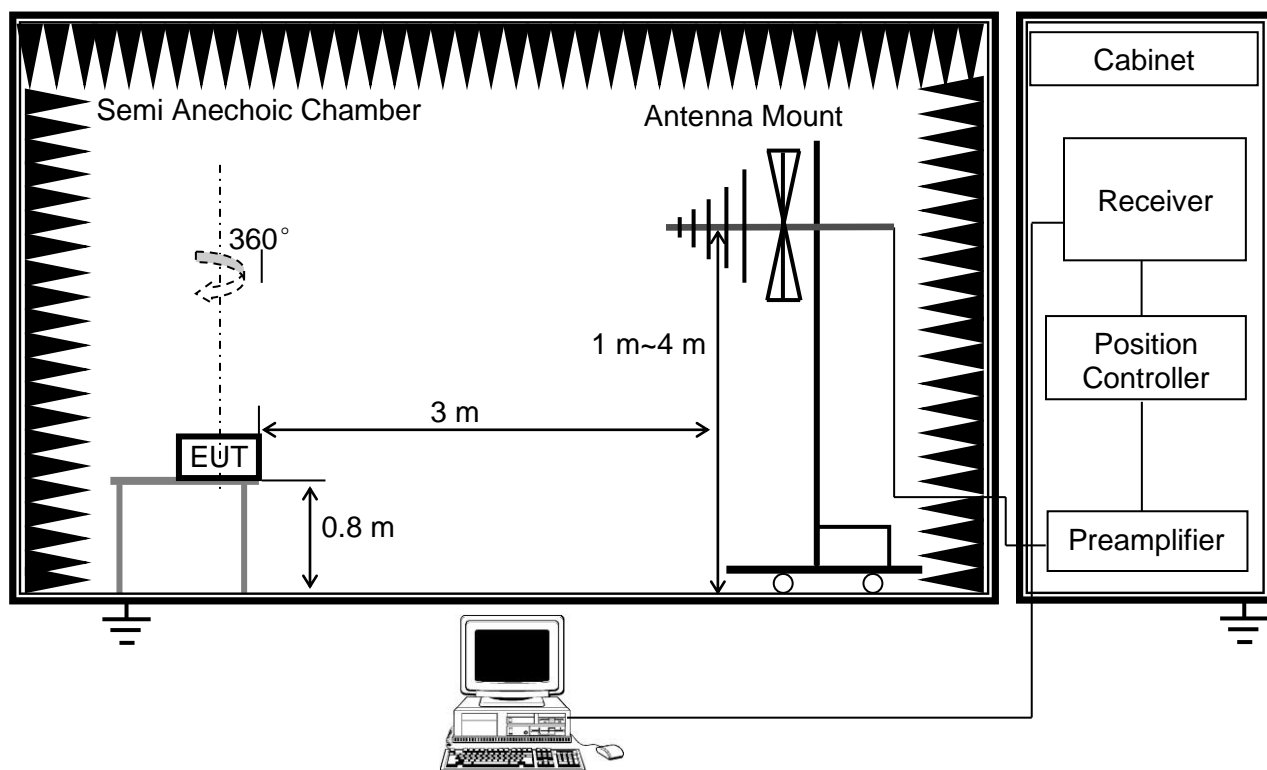


### 7.2.2. Test Procedure

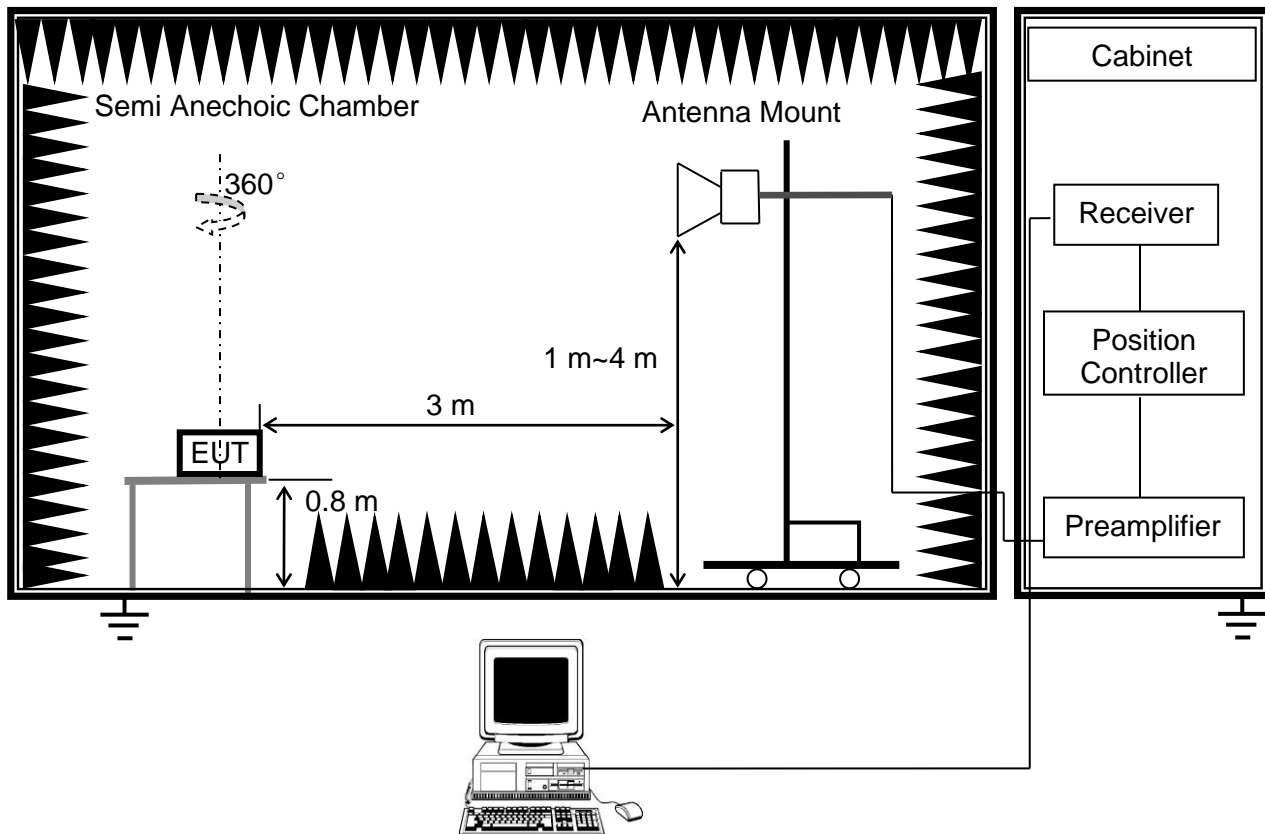
- a. The measuring distance at 3 m shall be used for measurements.
- b. The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 meter chamber. The table was rotated 360 degrees to determine the position of the highest radiation.
- c. The height of the equipment shall be 0.8 m; the height of the test antenna shall vary between 1 m to 4 m. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For the actual test configuration, please refer to the related Item: Photographs of Test Configuration.

### 7.2.3. Test Setup

- (a) Radiated Emissions Test Set-Up Frequency 30 MHz-1 GHz



(b) Radiated Emissions Test Set-Up Frequency above 1 GHz



For the actual test configuration, please refer to Appendix I: Photographs of Test Configuration

**7.2.4. Test Environment**

Radiated Emissions up to 1 GHz		Radiated Emissions above 1 GHz	
Temperature:	23.2 °C	Temperature:	25.1 °C
Humidity:	58.7 %	Humidity:	63.0 %
Atmosphere Pressure	101 kPa	Atmosphere Pressure	101 kPa

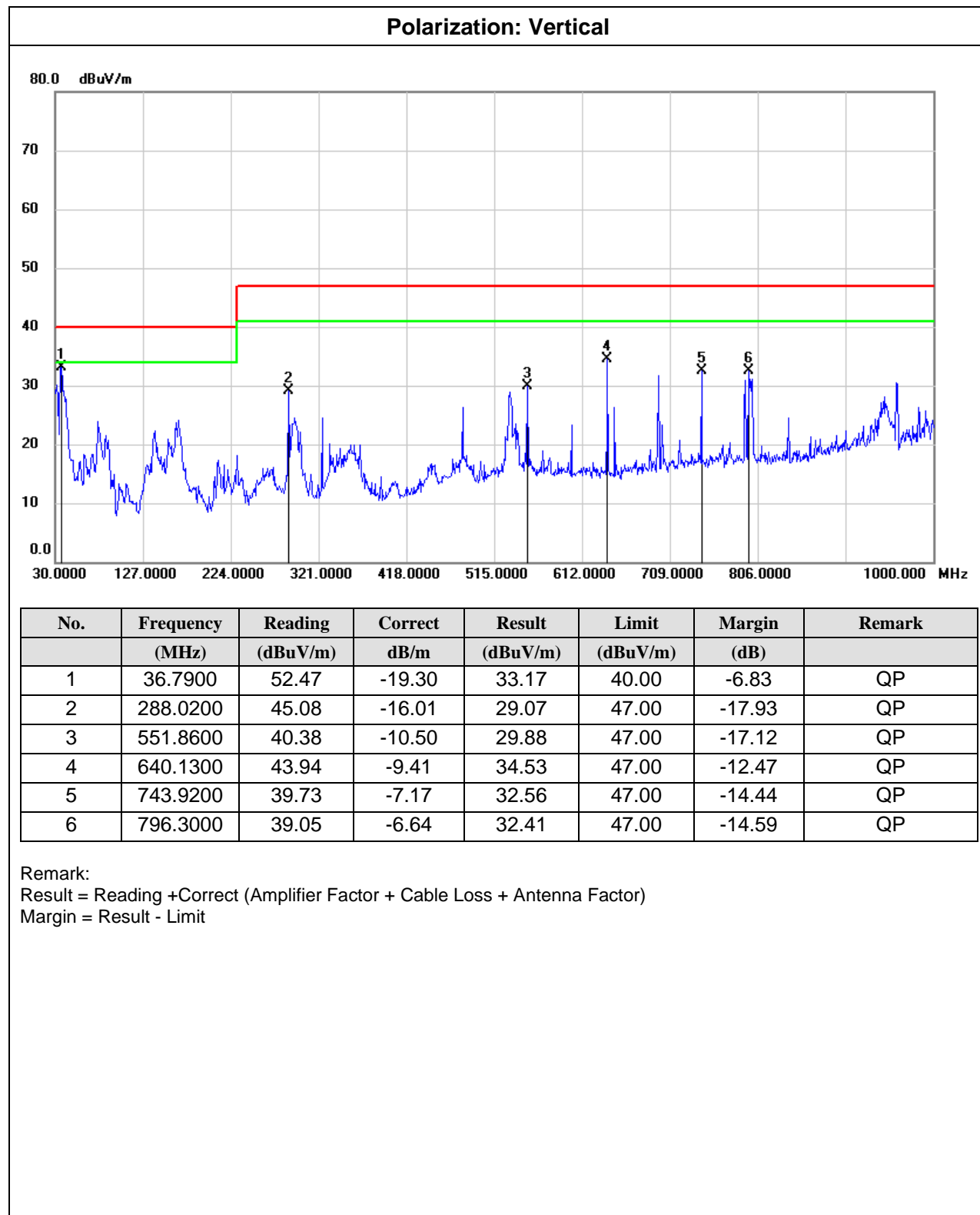
**7.2.5. Test Mode**

Radiated Emissions up to 1 GHz		Radiated Emissions above 1 GHz	
Pre-test Mode:	Mode 1 & Mode 2	Pre-test Mode:	Mode 1 & Mode 2
Final Test Mode:	Mode 2	Final Test Mode:	Mode 2

Note: All test modes have been tested, but only the worst case data recorded in the report.

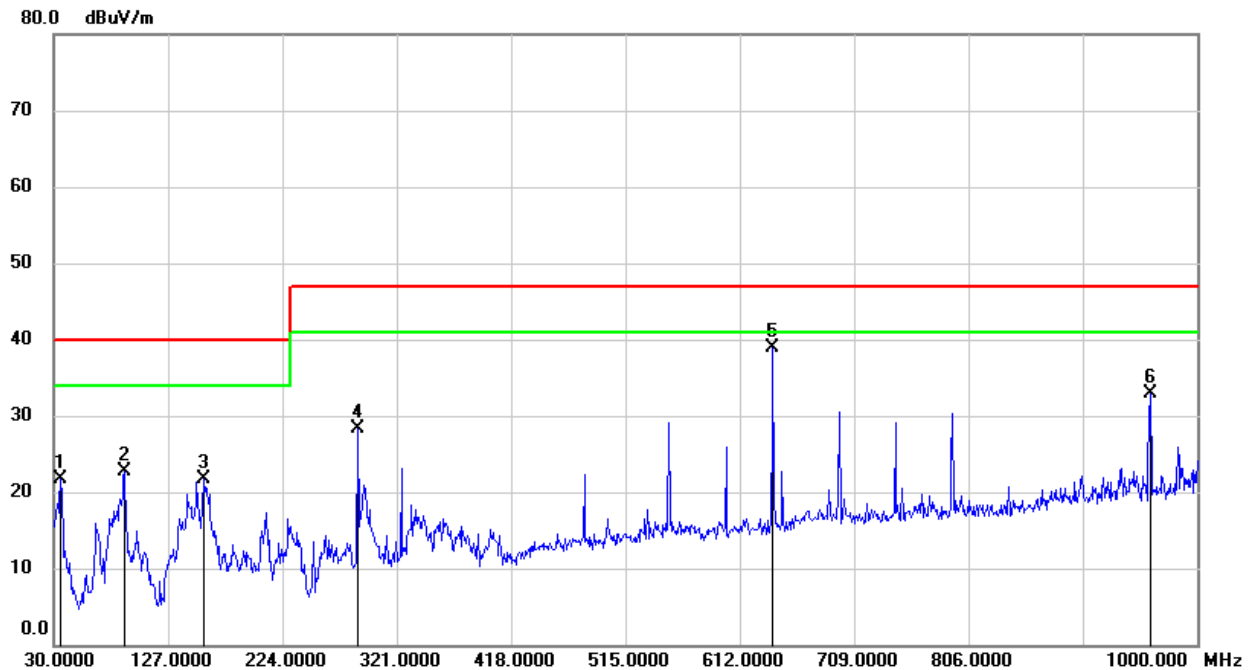
### 7.2.6. Test Results– up to 1 GHz

Test Mode:	Mode 2
Test Voltage:	AC 100V/60 Hz



Test Mode:	Mode 2
Test Voltage:	AC 100V/60 Hz

**Polarization: Horizontal**



No.	Frequency (MHz)	Reading (dBuV/m)	Correct (dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Remark
1	35.8200	40.76	-19.15	21.61	40.00	-18.39	QP
2	90.1400	44.82	-22.15	22.67	40.00	-17.33	QP
3	157.0700	39.55	-17.80	21.75	40.00	-18.25	QP
4	288.0200	44.38	-16.01	28.37	47.00	-18.63	QP
5	640.1300	48.22	-9.41	38.81	47.00	-8.19	QP
6	960.2300	37.62	-4.70	32.92	47.00	-14.08	QP

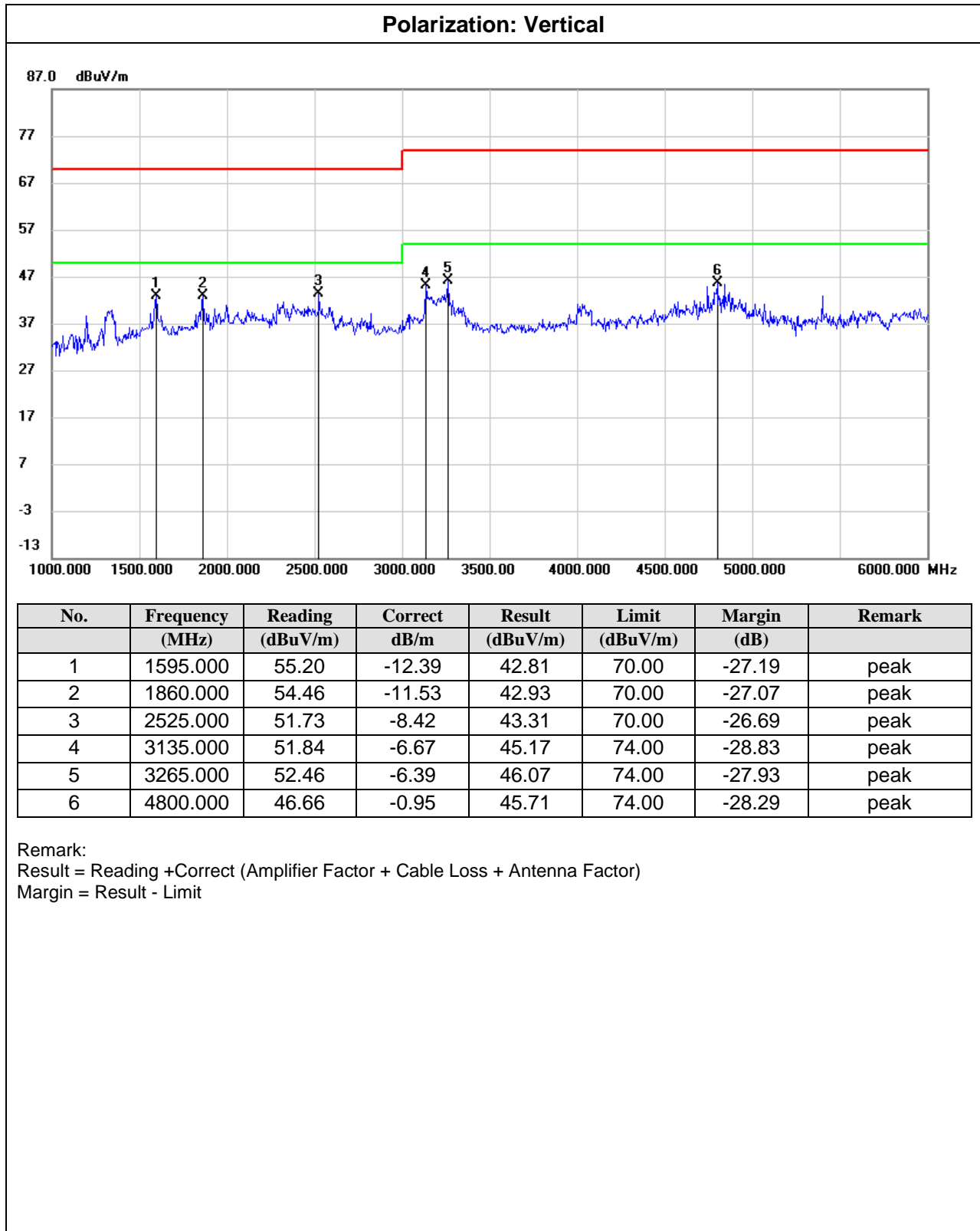
Remark:

Result = Reading + Correct (Amplifier Factor + Cable Loss + Antenna Factor)

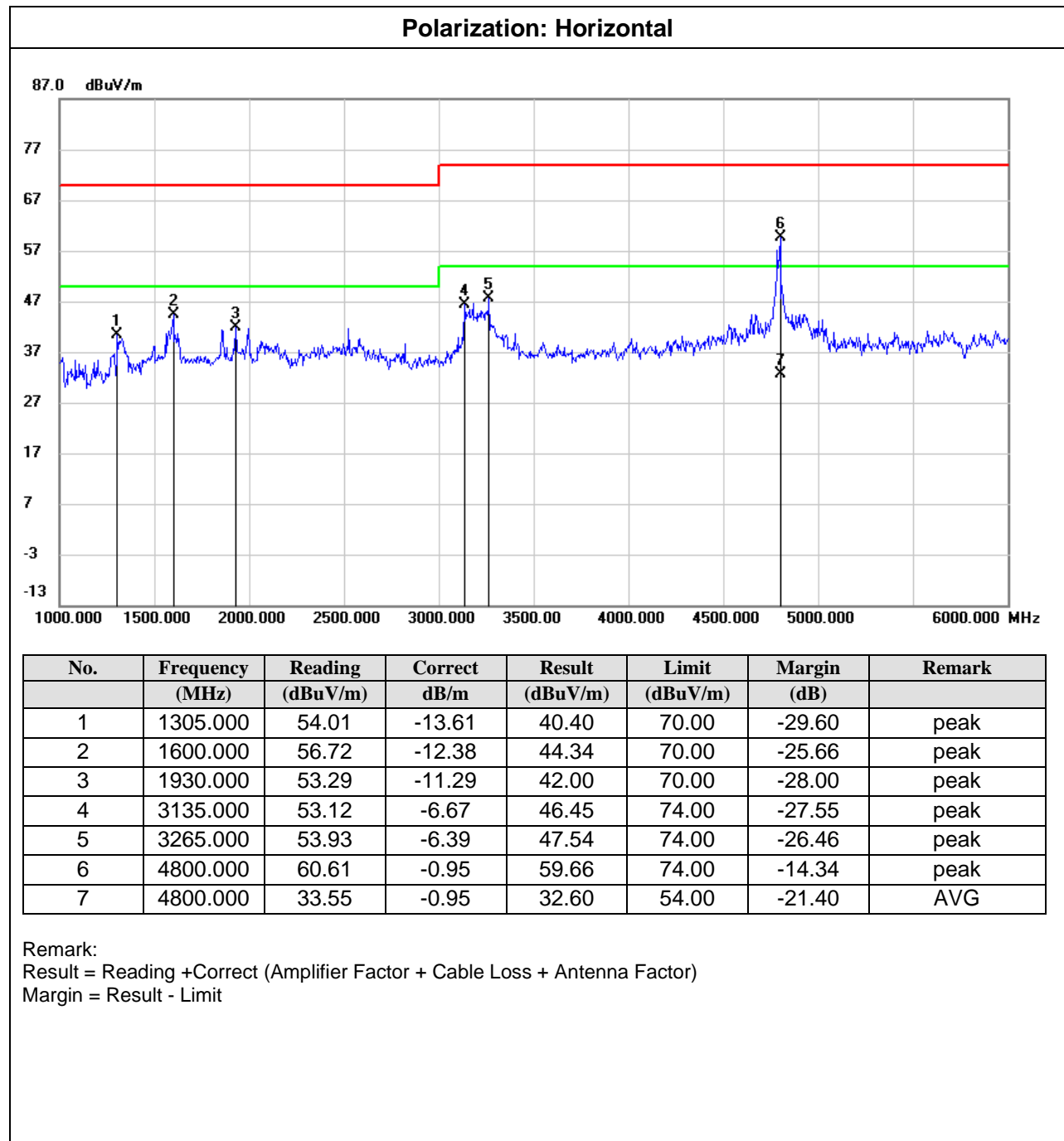
Margin = Result - Limit

### 7.2.7. Test Results – above 1 GHz

Test Mode:	Mode 2
Test Voltage:	AC 100V/60 Hz



Test Mode:	Mode 2
Test Voltage:	AC 100V/60 Hz

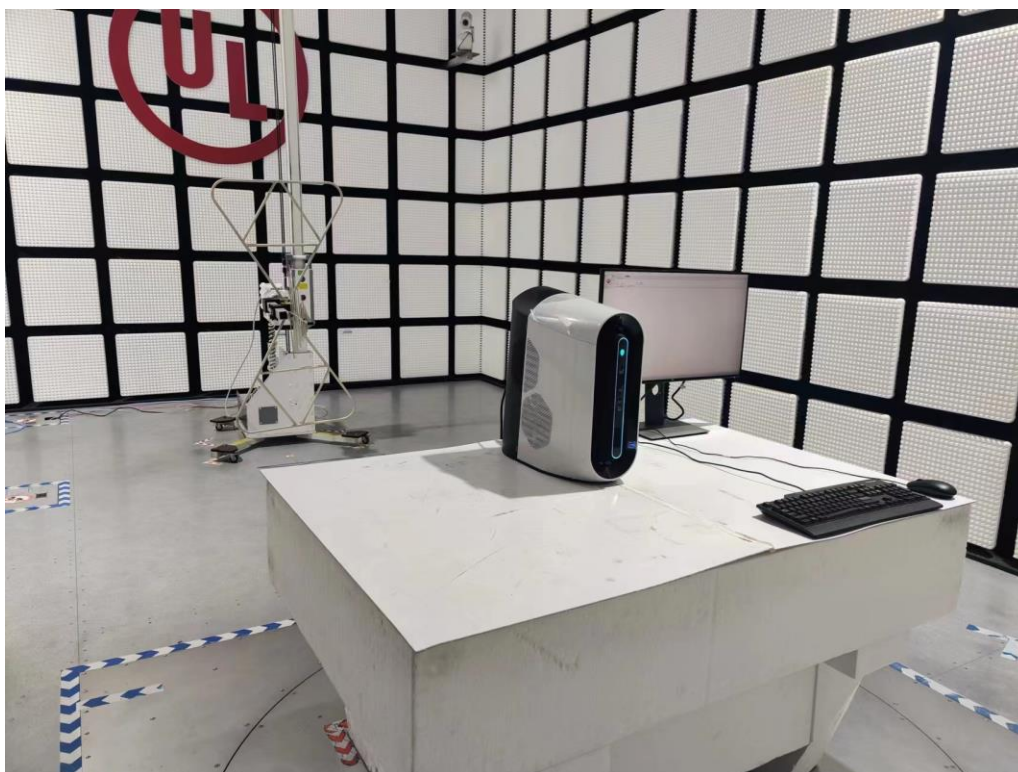


## Appendix I: Photographs of Test Configuration

Conducted Emissions test setup photo

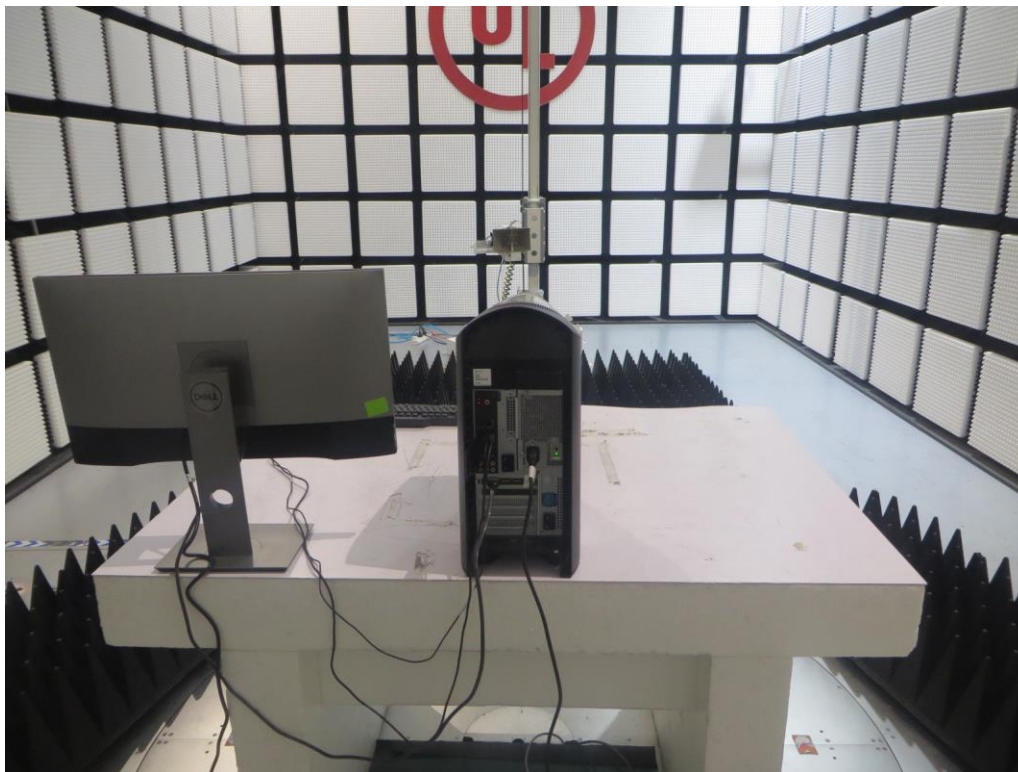


Radiated Emissions below 1 GHz test setup photo



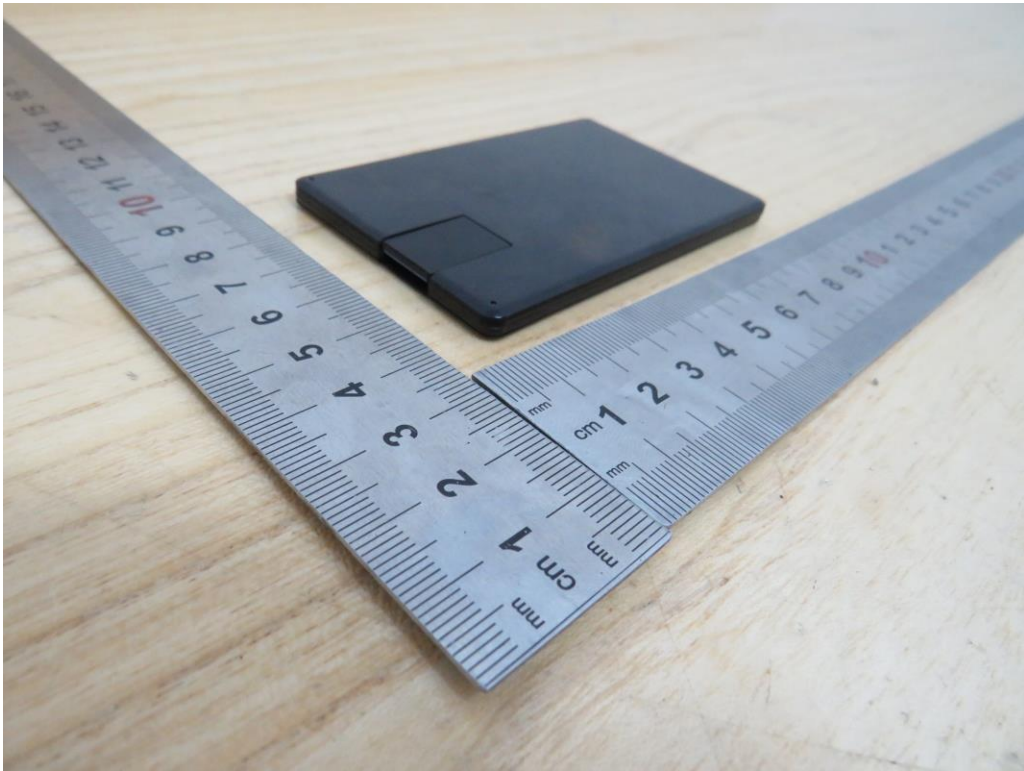


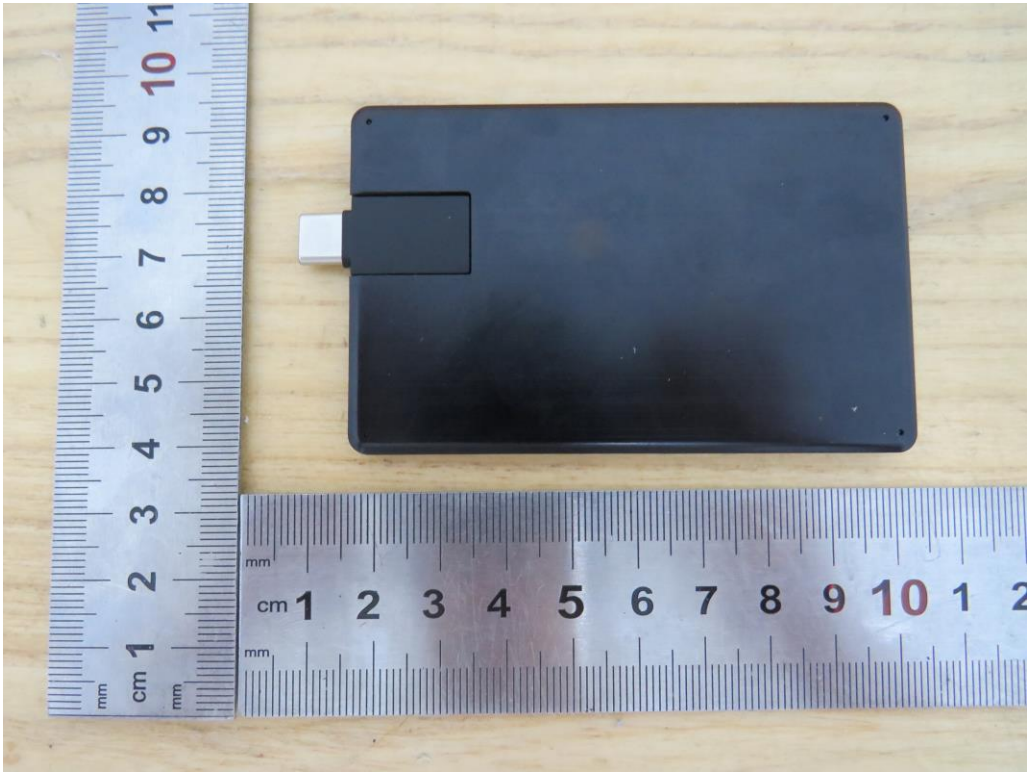
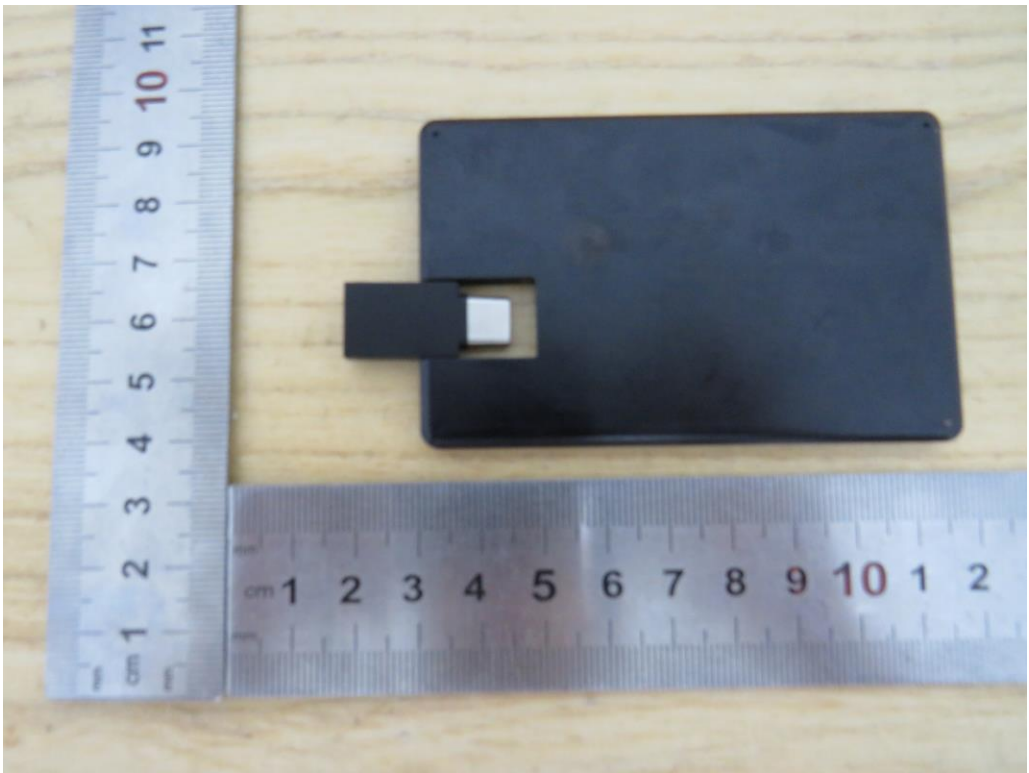
Radiated Emissions above 1 GHz test setup photo

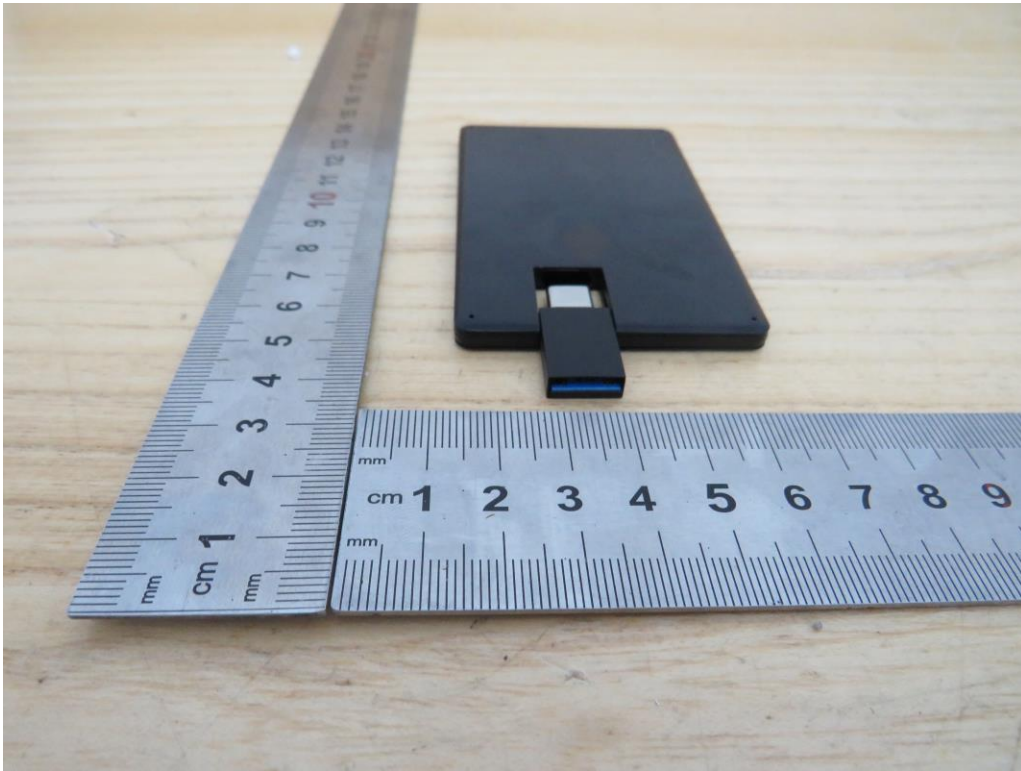


### Appendix II: Photographs of the EUT









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**END OF REPORT**